

| | Application/Control No. | Applicant(s)/Patent under Reexamination | |
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| | 10/749,602 | EMERY ET AL. | |
| ſ | Examiner | Art Unit | |
| l | Patricia Leith | 1655 | |

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| Class | Subclass | Date | Examiner |
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| SEARCH NOT (INCLUDING SEARCH | |) |
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| · | DATE | EXMR |
| EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE updated | 8/15/2009 | PL |
| Inventor name search updated EAST/PALM | 8/15/2009 | PL |
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